



PATENT
Docket No. 81208-246275

GAU: 2877
#7/B

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of :
Applicant: Nielsen, Henrik K., et al. :
Serial No.: 09/195,533 :
Filed: November 18, 1998 :
For: DETECTION SYSTEM FOR :
NANOMETER SCALE TOPOGRAPHIC :
MEASUREMENTS OF REFLECTIVE :
SURFACES :

Group Art Unit: 2877

Examiner: R. Rosenberger

Fee ok
RECEIVED
JUN 12 2000
6-13-00
L. Spruell

RESPONSE TO OFFICE ACTION

Assistant Commissioner for Patents
Washington, D.C. 20231

Sir:

In response to the Office Action dated March 3, 2000, please enter the following amendments and consider the following remarks in connection with the above-identified patent application.